Search Notes			
	Biiya ii 801 ibiib briss ibbya ibii iba		

F	Application/Control No.	Applicant(s)/Patent under Reexamination	
1	0/628,679	VICTOR THIELEN ET AL.	
E	xaminer	Art Unit	
F	Peter D. Mulcahy	1713	

SEARCHED				
Class	Subclass	Date	Examiner	
524	47,52	8/31/2005	PDM	
524	506,571	8/31/2005	PDM	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEAR		Y)
	DATE	EXMR
east, inventor search	8/31/2005	PDM
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